Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/719,377	AWAD ET AL.
Examiner	Art Unit
DANH C. LE	2617

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Interferen	rce Search	1/18/07	DL	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Name Search	1/18/07	DC
( Check for double patent)		
EAST Search updated		
(US, USPUB, JPU, EPO, DEDWENT)		